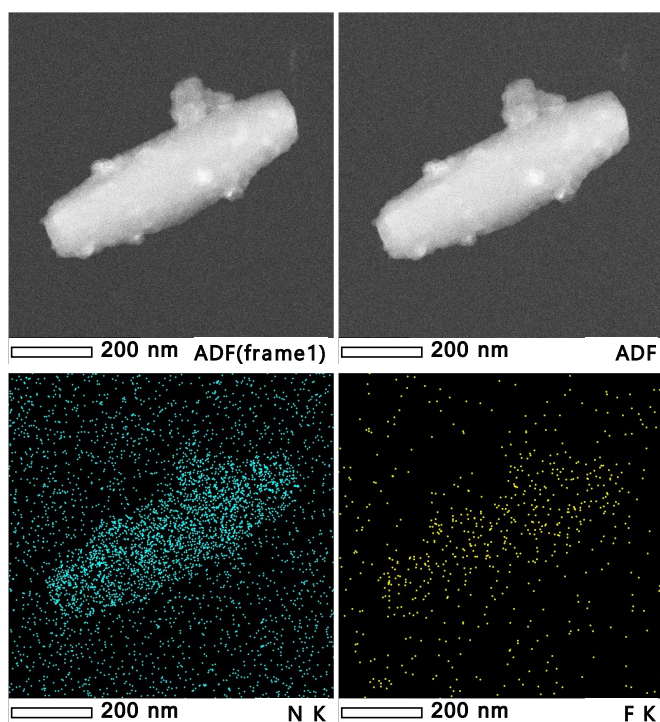


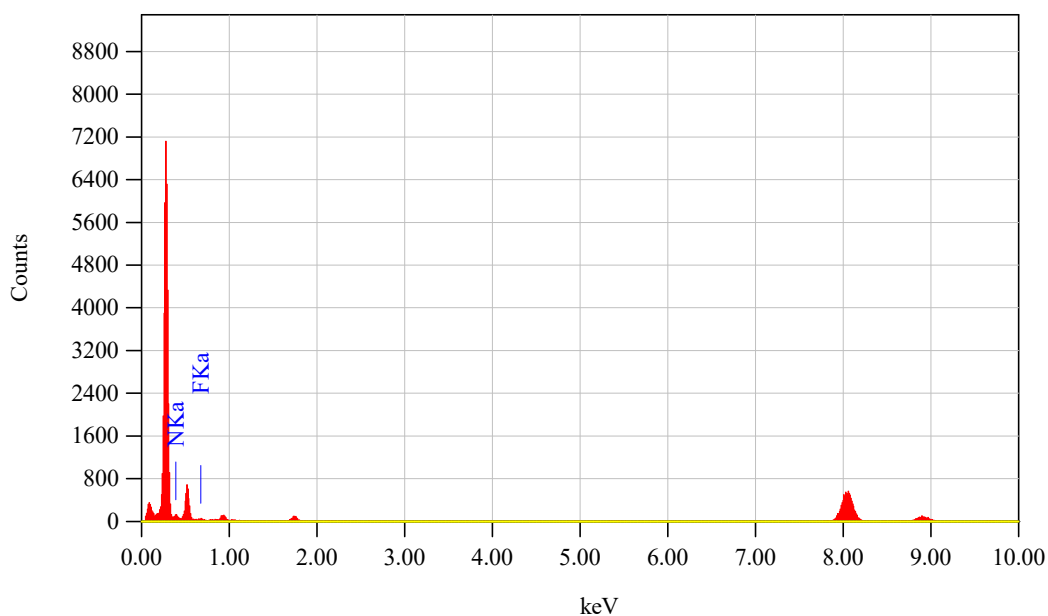
View006

JEOL 1/1



Date	: 3/21/2026
Resolution	: 512 x 512

Instrument	: JEM-F200 (U
Acc. Volt.	: 200 kV
Magnification	: x 250,000
Dwell Time	: 0.01 msec.
Sweep Count	: 41



Acquisition Parameter
 Instrument : JEM-F200 (URP)
 Acc. Voltage : 200.0 kV
 Probe Current: 7.47500 nA
 PHA mode : T4
 Real Time : 107.39 sec
 Live Time : 105.36 sec
 Dead Time : 1 %
 Counting Rate: 596 cps
 Energy Range : 0 - 40 keV

Thin Film Standardless Standardless Quantitative Analysis

Fitting Coefficient : 0.9967

Element	(keV)	Mass%	Counts	Sigma	Atom%	Compound	Mass%	Cation	K
N K (Ref.)	0.392	73.78	444.05	3.93	79.24				1.0000
F K	0.677	26.22	254.32	2.39	20.76				0.6206
Total		100.00			100.00				